

<b>Notice of References Cited</b>	Application/Control No. 09/772,051	Applicant(s)/Patent Under Reexamination SHIDA ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	C	US-5789056	08-1998	Bian et al.	428/332
	D	US-5583727	12-1996	Parkin et al.	360/113
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**NON-PATENT DOCUMENTS**

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	U	IEEE Transactions on Magnetics, Vol 28, #5, Sept. 1992, Paik et al. pp 3084-3086
	V	IEEE Transactions on Magnetics, Vol. 27, #6, Nov. 1991, Tani et al. pp 4736-4733
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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